


<b>Search Notes</b>  	<b>Application/Control No.</b>  10769786	<b>Applicant(s)/Patent Under Reexamination</b>  CHOI ET AL.
	<b>Examiner</b>  Nguyen, Jennifer T	<b>Art Unit</b>  2629

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	60-72,88-104	8/19/07	JN

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
east, IEEE, JPO	8/19/07	JN

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
315	169.1,169.4	8/19/07	JN